

<b>Notice of References Cited</b>	Application/Control No. 10/693,736	Applicant(s)/Patent Under Reexamination YUAN ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2006/0253463	11-2006	Wu et al.	707/010
*	C	US-2003/0232618	12-2003	Le et al.	455/412.2
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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